# Li's Formula Extended to Determine Accurate Resonant Frequency of a Rectangular Patch Antenna in Multi-Dielectric Layers

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**Abstract**—In this article, the drawbacks of Li's formula are rectified and extended to compute accurately the resonant frequency of a rectangular patch antenna in multi-dielectric layers. Computed results employing the present model are compared with experimental and simulation results. The present model shows excellent improvement in accuracy compared to the previously reported investigations.

# 1. INTRODUCTION

Nowadays microstrip patch antennas (MPA) are very popular, and they are widely used as an efficient sensor [1-3] both on fixed and portable devices [4,5] due of their several attractive features like light weight, low profile, small size, conformable structure, and easy fabrication. In outdoor application, the antenna performance degrades due to the formation of environmental hazards over the antenna. So, a dielectric cover layer is required to protect the patch from environmental hazards. When a dielectric cover layer is naturally formed or imposed by design, then the effective permittivity of the microstrip structure is changed. Thus, the resonant frequency is shifted. This shift in resonant frequency is used to measure the permittivity of a particular layer in a multi-dielectric layer. So, here the patch antenna behaves like a sensor. Thus the accurate computation of resonant frequency is very essential to use properly the patch antenna as a sensor. Recently, the patch antenna in multi-dielectric superstrate layer draws much attention of the researchers [5-23]. The resonant frequency mainly depends on effective permittivity of the microstrip structure, effective length and width of the patch. So, the accurate computation of these parameters is very crucial. Different theoretical methods have been reported to compute the resonant frequency of the patch in multi-dielectric layers using the variational method [7, 8], multiport network technique [9], and full wave analysis method [10-12]. All of these efforts give reasonably accurate results, but they involve large and rigorous mathematical steps and also take large computational time. The Maxwell or Helmholtz equations for computing the resonant frequency are also very complex and consists of rigorous mathematical steps. So, these techniques are not suitable for computation of the resonant frequency as well as direct synthesis of the patch antenna.

The commercial softwares (HFSS, CST) based on full wave analysis can also be used to compute the resonant frequency. The commercial softwares have also some inherent limitations like they need frequency range and matching impedance location point under the patch for computing the performance properties of the antenna. Without mathematical model, the frequency and matching impedance point are impossible to determine. So, softwares are also not suitable for the direct synthesis of patch antennas. Thus, engineers require a simple closed form model to compute the resonant frequency of a patch antenna loaded with several dielectric layers. The conformal mapping technique is a simple method which is highly suitable to compute the effect of a particular dielectric layer on effective permittivity as well as on

Received 29 August 2020, Accepted 14 November 2020, Scheduled 14 December 2020

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resonant frequency of a microstrip patch in multi-dielectric layers. The filling fraction for each dielectric layer is computed by using conformal mapping, and those parameters are used for computation of the effective relative permittivity of the multi-layered structure which ultimately modifies the resonant frequency. The conformal mapping is ideal for design purpose because it consists of fewer mathematical steps and provides closed form expressions. This technique also directly applies to the CAD program and requires less computational time. Thus, conformal mapping technique is employed to investigate the rectangular patch in multi-dielectric structure.

The commercial software HFSS has taken a few minutes time to simulate an antenna (as in Fig. 1), for a usual solver setting (number of passes 50, fast sweep, and frequency step size 0.0005 GHz) in a personal computer having Core i3 processor and 4 GB RAM, whereas the proposed model takes only a fraction of a second to solve the same. So, the proposed model is much faster than simulators and numerical techniques.

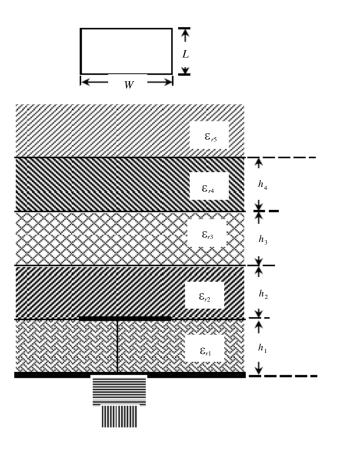


Figure 1. Top view and cross-sectional view of a rectangular patch in multi-dielectric layers.

In order to calculate the resonant frequency of a rectangular patch in multi-dielectric layer, the conformal mapping technique has been employed in [1, 5, 13-17]. Among them [1, 13-16] employed an approximate capacitance formula and erroneous filling fraction arrangements for effective permittivity computation. Also they [13-16] have not incorporated the effect of surface wave and leaky wave in effective length calculation. Later on two efficient conformal mapping approaches were reported in [5, 17]. They [5, 17] used rectified filling fraction arrangements and incorporated the effect of surface wave in effective length calculation. However, these models [5, 17] had some drawbacks: (i) did not consider the effect of leaky wave mode in effective length calculation, (ii) showed higher error for higher permittivity structure, and (iii) valid for only one dielectric cover layer. Very recently, another research group [6] has reported an efficient conformal mapping approach which includes rectified filling fraction arrangements and also incorporates the effect of surface wave. It is also valid for a higher permittivity multilayered structure. However, the model [6] still has some drawbacks: (i) they incorporated the fringing field effect

#### Progress In Electromagnetics Research M, Vol. 99, 2021

twice in effective length calculation which is theoretically incorrect; (ii) they did not consider the effect of leaky wave modes in effective length computation; (iii) the previous models [15–21] reported that the resonant frequency of a rectangular patch antenna in multi-dielectric layers decreased with the increase of dielectric cover layer thickness. The article in [22] shows experimentally that the resonant frequency decreases monotonically with the increase of superstrate thickness. The simulation results (HFSS and CST) also support the same nature of previously reported theoretical [15–21] and experimental results [22]. However, the computed resonant frequency using the model [6] shows opposite nature with cover layer thickness which is incorrect. This is based on the fact that the article [6] erroneously calculates the filling fraction of the top layer (air) of the multilayered structure. This is clearly depicted in Fig. 2. The details of the discrepancies are explained in the theory section.

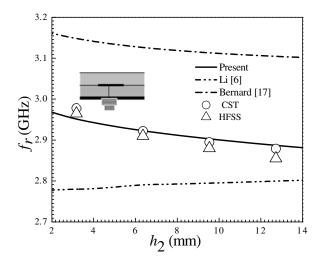


Figure 2. Variation of dominant mode resonant frequency of an ETPA covered with single dielectric layer with the change of dielectric cover thickness  $h_2$ . W = 33.0 mm, L = 28.0 mm,  $h_1 = 3.18 \text{ mm}$ ,  $h_3 = \infty$ ,  $h_4 = 0.0 \text{ mm}$ ,  $\varepsilon_{r1} = \varepsilon_{r2} = 2.32$ ,  $\varepsilon_{r3} = \varepsilon_{r4} = \varepsilon_{r5} = 1.0$ .

Considering these inconsistencies of the previous approaches carefully, the development of the present article includes (i) rectification of Li's model and extension to compute the effective permittivity more accurately of the rectangular patch in a multi-dielectric structure, (ii) accurate computation of the effective side length, (iii) inclusion of the effect of leaky wave as well as the surface wave modes in effective length computation, and (iv) validation of the present model with performed experiments, other measurement and simulated values.

# 2. THEORY

The article [6] reported an expression for computing the resonant frequency for a rectangular patch antenna in multi-dielectric layers (Fig. 1), as

$$f_{r,nml} = \frac{c}{2\left(L_{eff} + 2\Delta L\right)\sqrt{\varepsilon_{r,eff}}}\tag{1}$$

where  $\Delta L$  is the edge extension due to the fringing fields at the edges of the patch, and it was computed from [23] in the paper [6].  $\Delta L$  strongly depends on relative characteristics of substrate and dielectric cover layers. The expression of  $\Delta L$  reported in [23] is actually for a rectangular geometry without any dielectric cover layer. The authors in [6] used  $W_{eff}$  in the place of W and  $\varepsilon'_r$  in the place of  $\varepsilon_r$  for incorporating the dielectric cover layer effect in  $\Delta L$ . The expressions of  $W_{eff}$  and  $\varepsilon'_r$  are obtained from [6] as

$$W_{eff} = \sqrt{\frac{\varepsilon_r'}{\varepsilon_{r,eff}}} \left[ \left\{ W + 0.882h_1 + 0.164h_1 \frac{(\varepsilon_r' - 1)}{(\varepsilon_r')^2} \right\} + h_1 \frac{(\varepsilon_r' - 1)}{\pi \varepsilon_r'} \left\{ \ln(0.94 + W/2h_1) + 1.451 \right\} \right] (2)$$

Biswas, Banik, and Dam

$$\varepsilon_{r}' = \frac{2\varepsilon_{r,eff} - 1 + \left(1 + \frac{10h_{1}}{W_{eff}}\right)^{-1/2}}{1 + \left(1 + \frac{10h_{1}}{W_{eff}}\right)^{-1/2}}$$
(3)

The final values of  $W_{eff}$  and  $\varepsilon'_r$  are determined by two-step iteration [17].

 $L_{eff}$  is the effective length of the patch. The expression of  $L_{eff}$  was reported in [6] as

$$L_{eff} = L \, (1+q)^{\frac{1}{2}} \tag{4}$$

here, q is the fringing field factor which again arises due to the fringing fields at the edges of the patch lengths and was computed from [24]. In [6], they have put  $\varepsilon_{re} = \varepsilon_{r1}/\varepsilon_{r,eff}$  to account the effect of substrate and dielectric cover layers. q is also modulated significantly with the relative characteristics of substrate and dielectric cover layers.

Now both  $\Delta L$  and q arise due to the fringing fields, and both of them have been considered for computing the effective length in [6]. So, Equations (1), (4) [(12) and (13)] of [6] indicate that the article in [6] has incorporated the fringing field effect twice in effective length calculation which is incorrect. To the best of our knowledge, expression (1) was employed first in [6].

Most of the researchers [1, 2, 7-10, 15, 17, 25-36] have used the expression of a rectangular patch with and without dielectric cover layer for computing the resonant frequency instead of Equation (1) as

$$f_{r,nml} = \frac{c}{2\left(L + 2\Delta L\right)\sqrt{\varepsilon_{r,eff}}}\tag{5}$$

Some of the researchers [5, 16, 37–41] have also employed the expression for computing the resonant frequency of rectangular patch with and without dielectric cover layer instead of Equation (1) as

$$f_{r,nml} = \frac{c}{2L_{eff}\sqrt{\varepsilon_{r,eff}}}\tag{6}$$

So, either Equation (5) or (6) is correct to compute the resonant frequency of a rectangular patch antenna with and without dielectric cover layer. We have used Equation (5) to compute the resonant frequency.

In this article, we have employed the length extension  $\Delta L$  due to fringing fields effect as [26]:

$$\Delta L = \frac{\pi r \left(\sqrt{1+q}-1\right)}{2 \left(2.5-0.5W/L\right)} \tag{7}$$

Here, q is the fringing field factor, and it is evaluated from [42, (2), (3)] with  $r = L/(\pi - 2)$  [6].

$$q = q_1 + (1 + q_1)(q_2 + q_3) \tag{8}$$

$$q_1 = \left(1 + \varepsilon_{re}^{-1}\right) \left(4h_1/\pi r\right) \tag{9}$$

$$q_2 = (2/3) \left\{ (0.37 + 0.63\varepsilon_{re})^{-1} (8 + \pi r/h_1)^{-1} \right\}$$

$$= \left\{ \int \left\{ (1 + 0.0 + (l_1)^2 + (0.21 + (l_2)^4) (1 + 0.0 + (l_1)^{-1}) \right\} \right\}$$
(10)

$$\times \ln\left[\left\{1+0.8\left(r/h_{1}\right)^{2}+\left(0.31r/h_{1}\right)^{4}\right\}\left(1+0.9r/h_{1}\right)^{-1}\right]$$
(10)

$$q_3 = \left(4 + 2.6r/h_1 + 2.9h_1/r\right)^{-1} \left\{ \left(0.37 + 0.63\varepsilon_{re}\right)^{-1} - 1 \right\}$$
(11)

The article reported in [20] has introduced a new relative permittivity  $\varepsilon_{re}$  of a multilayered structure for accounting the effect of surface wave due to surface wave mode.  $\varepsilon_{re}$  is used to compute the fringing field factor q. The  $\varepsilon_{re}$  for multi-layered structure was defined in [20] as

$$\varepsilon_{re} = \frac{\varepsilon_{r1}}{\varepsilon_{r,eff}} \tag{12}$$

The derivation for computing  $\varepsilon_{re}$  was not reported in [20], and only the expression was provided [20, Equation (11)]. Here we have accounted the effect of leaky wave mode in a similar manner of surface wave mode [20]. The leaky wave is accounted in terms of fringing field. This fringing field very much

180

#### Progress In Electromagnetics Research M, Vol. 99, 2021

depends on the relative characteristics of the substrate and dielectric cover layer. Recently, the effect of leaky wave mode on microstrip structure draws much attention of the researchers [43–46]. These studies show that the leaky wave due to leaky wave mode has significant impact on antenna performances. The leaky wave due to leaky wave mode very much depends on the relative characteristics of substrate and dielectric cover layers as indicated by [45, 46]. They [45, 46] showed that leaky wave due to leaky wave mode will be reduced very much when the relative permittivity of the dielectric cover layer is larger than that of the substrate for a particular substrate and dielectric cover layer thickness combination. We have accounted the effect of both surface wave and leaky wave in effective patch length computation for further improvement in results. Based on these two facts (surface wave and leaky wave modes), we have proposed a new relative permittivity to compute the fringing field as

$$\varepsilon_{re} = \frac{\varepsilon_r'}{\varepsilon_{r,eff}} \tag{13}$$

With this new relative permittivity more improvement in results is obtained.  $\varepsilon'_r$  is defined in Equation (3). We have put the value of  $\varepsilon_{re}$  from Equation (13) instead of Equation (12) for computing fringing filed factor q [in Equations (9)–(11)]. All the models reported in [1, 5, 6, 7, 13–17] did not consider the effect of leaky waves in effective length calculation. The justification of Equation (13) is verified in result section in Table 4. From the above discussion it is understood that we have incorporated the fringing field effect once in effective length computation.

For computing the effective permittivity, Svacina employed conformal mapping technique for generalized multilayered microstrip [14]. Here, the patch is placed on single substrate and covered by four dielectric superstrate layers (top layer is air) as depicted in Fig. 1. Now, the structure is mapped onto a complex g-plane (g = u + iv) in Fig. 3 using conformal mapping techniques as described by Svacina [14]. The ratio of each dielectric area  $A_i$  (i = 1, 2, ..., 5) to the total area of the cross section  $A_{tot}$  in the g-plane is defined as filling fraction for each layer. The filling fractions ( $p_i = A_i/A_{tot}$ ) for these five layers are expressed as

$$p_1 = \frac{A_1}{A_{tot}} = 1 - \frac{h_1}{2W_{eff}} \ln\left(\frac{\pi}{h_1}W_{eff} - 1\right)$$
(14)

$$p_{i} = \frac{A_{i}}{A_{tot}} = \frac{h_{1}}{2W_{eff}} \left\{ \ln\left(\frac{\pi}{h_{1}}W_{eff} - 1\right) - (1 + g_{i}) \times \ln\left[\frac{2W_{eff}}{h_{1}}\frac{\cos\left(\frac{\pi}{2}g_{i}\right)}{\frac{2h_{i}}{h_{1}} - 1 + g_{i}} + \sin\left(\frac{\pi}{2}g_{i}\right)\right] \right\}$$
(15)  
$$i = 2, 3, 4$$

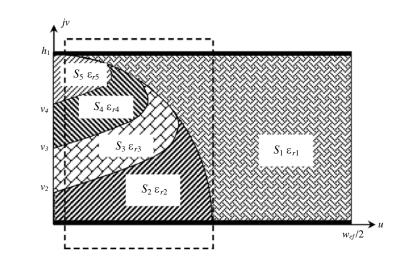


Figure 3. Equivalent parallel plate arrangement using conformal mapping.

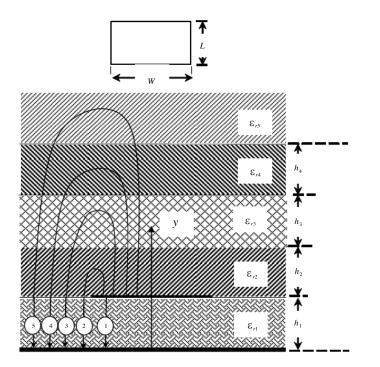


Figure 4. Electric flux in different paths for the structure depicted in Fig. 1.

$$g_i = \frac{2}{\pi} \arctan\left[\frac{\pi}{\frac{\pi}{2}\frac{W_{eff}}{h_1} - 2} \left(\frac{h_i}{h_1}\right) - 1\right]$$
(16)

where  $W_{eff}$  is computed from Equation (2).

$$p_5 = 1 - \sum_{j=2}^{4} p_j - p_1 \quad i = 2, 3, 4 \tag{17}$$

**¬** −1

Now, the important situation is that when any of the top superstrate layers is absent, the filling fraction of the corresponding layer should be zero. However, in this situation the filling fraction of the top superstrate layers computed from Equation (15) provides a non-zero value. It means that the value of top layers filling fractions is overestimated. To correct this discrepancy, filling fractions are required to recalibrate. Now, to correct these filling fractions we require to study the paths of the electric field flux lines from patch to ground plane (Fig. 4). From Fig. 4, it is observed that the electric field flux lines from patch can propagate through five different paths to reach the ground plane. In path 1, the flux remains within the substrate. For paths 2 to 4, the flux lines propagate in substrate and top superstrate layers with different relative permittivities, and in path 5, the flux lines pull out to the space. The arrangements of the new filling fractions based on these electric field flux lines from patch to ground plane are depicted in Fig. 5. Now, the recalibrated filling fractions may be expressed as [6]:

$$p_{11} = p_1 - 2p_{20} - p_{40} \tag{18}$$

$$p_{ii} = \left[1 - p_{11} - p_5 - 2p_{20} - p_{30} - p_{40}\right] \times (p_i - p_{i0}) \left[\sum_{j=2}^4 p_j - p_{j0}\right]$$
(19)  
$$i = 2, 3, 4$$

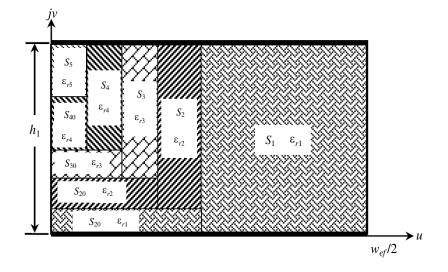


Figure 5. Filling fraction arrangement following the electric flux paths depicted in Fig. 4 for effective permittivity computation.

$$p_{i0} = \frac{h_1}{2W_{eff}} \left\{ \ln\left(\frac{\pi}{h_1}W_{eff} - 1\right) - (1 + g_{i-1}) \times \ln\left[\frac{2W_{eff}}{h_1}\frac{\cos\left(\frac{\pi}{2}g_{i-1}\right)}{\frac{2h_{i-1}}{h_1} - 1 + g_{i-1}} + \sin\left(\frac{\pi}{2}g_{i-1}\right)\right] \right\} (20)$$
$$i = 2, 3, 4$$

Now, the article in [6] has taken the filling fraction for the top layer (air)  $p_5$  instead of  $p_{55}$  for the computation of  $\varepsilon_{r,eff}$ , which shows the variation of resonant frequency with dielectric cover layer thickness opposite in nature. The validation of this statement is verified in Fig. 2.  $p_5$  is the initial approximate filling fraction of top layer (air). Here, we propose the rectified filling fraction  $p_{55}$  for the top layer as

$$p_{55} = 1 - \sum_{j=2}^{4} p_{jj} - p_{11} \tag{21}$$

With this rectified filling fraction, we have computed correct value of  $\varepsilon_{r,eff}$  which shows that the computed resonant frequency decreases with the increase of dielectric cover layer thickness (Fig. 2).

Considering these recalibrated filling fractions, the effective permittivity of this structure (as in Fig. 5) can be computed as [6]:

$$\varepsilon_{r,eff} = \varepsilon_{r1}p_{11} + \varepsilon_{r1}u \left(p_{22} + p_{33} + p_{44} + p_{55} + 4p_{20}\right)^2 \\ \times \left[\varepsilon_{r1} \left(p_{22} + p_{33} + p_{44} + p_{55} + 3p_{20}\right)^2 + up_{20}\right]^{-1}$$
(22)  
$$u = \varepsilon_{r2}p_{22} + \varepsilon_{r2} \left(\varepsilon_{r3}p_{33} + v\right) \left(p_{33} + p_{44} + p_{55} + 3p_{20}\right)^2 \\ \times \left[\varepsilon_{r2} \left(p_{33} + p_{44} + p_{55} + 2p_{20}\right)^2 + \left(\varepsilon_{r3}p_{33} + v\right) p_{20}\right]^{-1}$$
(23)

and

$$v = \varepsilon_{r3} \left[ \varepsilon_{r4} p_{44} + \varepsilon_{r4} \varepsilon_{r5} \left( p_{55} + p_{20} \right)^2 \times \left( \varepsilon_{r4} p_{55} + \varepsilon_{r5} p_{20} \right)^{-1} \right] \\ \times \left( p_{44} + p_{55} + 2p_{20} \right)^2 \times \left\{ \varepsilon_{r3} \left( p_{44} + p_{55} + p_{20} \right)^2 + p_{20} \\ \times \left[ \varepsilon_{r4} p_{44} + \varepsilon_{r4} \varepsilon_{r5} \left( p_{55} + p_{20} \right)^2 \times \left( \varepsilon_{r4} p_{55} + \varepsilon_{r5} p_{20} \right)^{-1} \right] \right\}$$
(24)

## 3. ANTENNA DESIGN AND EXPERIMENTAL TESTS

A prototype has been etched on Taconic dielectric substrates ( $\varepsilon_{r1} = 2.33$ ,  $h_1 = 0.7875$  mm). The patch is excited with a coaxial probe whose diameter g = 1.24 mm. Different dielectric substrates like Taconic, Rogers, Glass epoxy, Arlon, etc. with different thicknesses and relative permittivities used as dielectric cover layers. To validate the model developed in Section 2, we perform a set of experiments using Network Analyzer Agilent-E5071B. It is very easy to find the resonant frequency of an antenna using network analyzer. During the testing of an antenna with network analyzer, the resonant frequency can be measured from — (i) impedance locus in Smith chart (at zero reactance value) or (ii)  $s_{11}$  variation (minimum value of  $s_{11}$  point). Here we follow the second approach to find resonant frequency.

# 4. RESULTS AND DISCUSSIONS

Today several articles have been published in different renowned journals using the results based on simulation tools (HFSS, IE3D, CFDTD, CST, etc.) because simulation provides quite accurate results within a short time very easily. In this article, most of the HFSS simulated values of Rectangular Patch Antenna in Multi-dielectric Layers (Tables 2, 3, 4) are taken from the article [6]. We have also employed HFSS in Table 1 in this paper comfortably for a usual solver setting (number of passes 50, fast sweep and frequency step size 0.0005 GHz) in a personal computer having Core i3 processor and 4 GB RAM which gives the results within a few minutes.

**Table 1.** Comparison of theoretical, HFSS simulation and experimental resonant frequencies for a rectangular patch sensor covered with three layered dielectric superstrates.  $W = 30.0 \text{ mm}, L = 24.0 \text{ mm}, h_1 = 0.7875 \text{ mm}, h_2 = h_4 = 0.8265 \text{ mm}, \varepsilon_{r1} = 2.33, \varepsilon_{r2} = \varepsilon_{r4} = 2.4, \varepsilon_{r5} = 1.0.$ 

	$h_3 \ (\mathrm{mm})$	Resonant frequency (GHz)						
$\varepsilon_{r3}$		Exp.	HFSS	Computed				
				Present	$\mathrm{Li}^{1}$	$\mathrm{Li}^2$		
2.2	0.508	3.799	3.791	3.748	3.975	3.896		
2.33	0.7875	3.792	3.785	3.746	3.974	3.894		
2.33	1.575	3.753	3.780	3.743	3.987	3.909		
2.33	1.58	3.739	3.778	3.743	3.987	3.909		
2.55	2.34	3.729	3.736	3.736	3.979	3.900		
5.0	1.63	3.695	3.720	3.696	3.950	3.868		
5.6	1.4	3.689	3.710	3.692	3.941	3.858		
10.0	1.63	3.611	3.615	3.620	3.909	3.823		
Avera	Average $\%$ Error with respect to Exp				6.374	4.208		
Avera	Average $\%$ Error with respect to HFSS				5.988	3.830		

Li<sup>1</sup>: Used corrected Equation (5) for  $f_r$  calculation [6].

Li<sup>2</sup>: Used corrected Equation (6) for  $f_r$  calculation [6].

It has already been mentioned in theory section that the expression employed in [6] for calculating the effective length was erroneous. So, for the model in [6], we have taken correct expressions (5) and (6) in the entire experimental tables.

### 4.1. Sensor Covered with Three Dielectric Layered Structures

In Table 1, we compare our experimental and simulated (HFSS) resonant frequencies with theoretical values for a rectangular patch sensor covered with a three layered dielectric superstrate. Now from this comparison it is clear that the computed resonant frequencies employing the present model are more accurate and far better than [6].

**Table 2.** Comparison of theoretical, HFSS simulation and experimental resonant frequencies for a rectangular patch sensor covered with three layered dielectric superstrates.  $W = 10.0 \text{ mm}, L = 10.0 \text{ mm}, h_1 = 0.98 \text{ mm}, h_2 = h_4 = 0.508 \text{ mm}, \varepsilon_{r1} = 1.046, \varepsilon_{r2} = \varepsilon_{r4} = 3.27, \varepsilon_{r5} = 1.0.$ 

$\varepsilon_{r3}$	$h_3 \ (\mathrm{mm})$	Resonant frequency (GHz)						
		Exp. [6]	HFSS	Computed				
				Present	$\mathrm{Li}^{1}$	$\mathrm{Li}^2$		
1	1.100	11.150	10.975	10.737	12.199	12.224		
1.046	1.100	11.175	10.975	10.718	12.180	12.197		
1.067	10.200	11.350	11.150	10.878	12.415	12.526		
1.093	10.200	11.325	11.125	10.850	12.390	12.491		
2.1	1.000	10.700	10.525	10.374	11.776	11.639		
3.00	0.508	10.575	10.375	10.270	11.595	11.390		
4.5	0.508	10.350	10.175	10.051	11.398	11.125		
6.00	0.635	9.950	9.850	9.755	11.159	10.804		
6.15	0.635	9.900	9.775	9.734	11.144	10.785		
9.20	0.635	9.475	9.425	9.333	10.906	10.468		
9.8	0.635	9.475	9.375	9.261	10.868	10.419		
10.2	0.635	9.400	9.325	9.214	10.845	10.387		
Avera	ige % Error	with resp	2.862	11.409	9.322			
Averag	ge % Error	with respe	1.488	12.979	10.871			

Li<sup>1</sup>: Used corrected Equation (5) for  $f_r$  calculation [6].

Li<sup>2</sup>: Used corrected Equation (6) for  $f_r$  calculation [6].

The validity of the present model for a rectangular patch sensor covered with a three-layered dielectric superstrate is further validated in Table 2. Here the computed values employing the present model and model reported in [6] are compared with the measurement in [6]. The computed resonant frequencies employing the present model show excellent agreement with simulated and experimental results compared to the model in [6].

## 4.2. Sensor Covered with Two Dielectric Layered Structures

In Table 3, we compare simulated and measured [6] resonant frequencies with theoretical values for a rectangular patch sensor covered with a two-layered dielectric superstrate. It is observed that the computed resonant frequencies employing the present model are in close correlation with simulation and measured [6] results compared to the model in [6].

# 4.3. Sensor Covered with Single Dielectric Layered Structures

In Table 4, different theoretical values of resonant frequency employing the present model and model reported in [6, 17] for a rectangular patch sensor covered with single layered dielectric superstrate are compared with measurement [6] and simulation (HFSS) values. The comparison shows that computed resonant frequencies employing present model show very close agreement with simulated and experimental results compared to others [6, 17].

More accurate results are obtained with the present model due to consideration of the proper filling fraction arrangement for top layer, correct effective patch length computation, and minimized effect of leaky wave as well as surface wave.

**Table 3.** Comparison of theoretical, HFSS simulation and experimental resonant frequencies a rectangular patch sensor covered with two layered dielectric superstrates. W = 10 mm, L = 10 mm,  $h_1 = 0.99 \text{ mm}$ ,  $h_4 = 0.00 \text{ mm}$ ,  $\varepsilon_{r1} = 1.046$ ,  $\varepsilon_{r3} = \varepsilon_{r4} = \varepsilon_{r5} = 1.0$ .

$\varepsilon_{r2}$	$h_2 \ (\mathrm{mm})$	$\varepsilon_{r3}$	$h_3 \ (\mathrm{mm})$	Resonant frequency (GHz)					
				Exp. [6]	HFSS	Computed			
						Present	$\mathrm{Li}^{1}$	$\mathrm{Li}^2$	
3.27	0.508	6.00	0.635	9.975	10.070	9.842	11.237	10.912	
		9.20	0.635	9.450	9.625	9.352	10.962	10.546	
6.00	0.635	3.27	0.508	9.700	9.675	9.553	10.583	10.583	
		9.20	0.635	8.900	8.825	8.757	9.409	9.409	
9.20	0.635	3.27	0.508	9.000	8.950	8.821	9.934	9.934	
		6.00	0.635	8.600	8.550	8.495	10.884	9.351	
Average % Error with respect to Exp					1.450	13.402	9.154		
	Average $\%$ Error with respect to HFSS						13.296	9.049	

Li<sup>1</sup>: Used corrected Equation (5) for  $f_r$  calculation [6].

 $\text{Li}^2$ : Used corrected Equation (6) for  $f_r$  calculation [6].

**Table 4.** Comparison of theoretical, HFSS simulation and experimental resonant frequencies a rectangular patch sensor covered with single dielectric superstrates.  $W = 10.0 \text{ mm}, L = 10.0 \text{ mm}, h_1 = 0.98 \text{ mm}, h_3 = \infty, h_4 = 0.0 \text{ mm}, \varepsilon_{r1} = 1.046, \varepsilon_{r3} = \varepsilon_{r4} = \varepsilon_{r5} = 1.0.$ 

$\varepsilon_{r2}$	$h_2 \ (\mathrm{mm})$	Resonant frequency (GHz)								
		Exp. [6]	HFSS	Computed						
				Present		$\mathrm{Li}^1$	$\mathrm{Li}^2$	$\mathrm{Ber}^1$		
				$\varepsilon_{re} = \varepsilon_r' / \varepsilon_{reff}$	$\varepsilon_{re} = \varepsilon_{r1} / \varepsilon_{reff}$		1.1	[17]		
3.00	0.508	11.325	11.325	11.136	10.927	12.761	13.019	12.173		
3.27	0.508	11.200	11.175	11.064	10.84	12.697	12.927	12.134		
4.50	0.635	10.950	10.750	10.617	10.302	12.335	12.414	11.972		
6.00	0.635	10.300	10.025	10.219	9.8258	12.014	11.966	11.706		
6.15	0.635	10.100	10.025	10.181	9.7805	11.984	11.925	11.688		
9.20	0.635	9.525	9.250	9.474	8.9432	11.459	11.207	11.361		
9.80	0.635	9.475	9.150	9.349	8.7953	11.370	11.088	11.305		
10.2	0.635	9.075	9.075	9.267	8.6994	11.314	11.012	11.268		
Avei	Average $\%$ Error with respect to Exp			1.437	4.729	17.370	16.751	14.661		
Avera	Average $\%$ Error with respect to HFSS			1.763	3.205	19.154	18.512	16.417		

Li<sup>1</sup>: Used corrected Equation (5) for  $f_r$  calculation [6]. Li<sup>2</sup>: Used corrected Equation (6) for  $f_r$  calculation [6].

Li<sup>2</sup>: Used corrected Equation (6) for  $f_r$  calculation [6].

 $Ber^1: [17].$ 

#### 5. CONCLUSION

In this article, a very simple and accurate model is presented to determine the resonant frequency of a rectangular patch antenna in multi-dielectric layers. This work is an extension of Li's work. The drawback of the prior work for computing the top layer filling fraction has been corrected for accurate computation of the effective permittivity. We have corrected the erroneous effective patch length expression of previous work. We have also minimized the effect of leaky wave in addition to surface wave for more tuning in results which is not reported earlier. The correction of Li's model as well as the consideration of leaky wave reduces error of the model with respect to the experimental and simulated results. Here the accuracy means accuracy with respect to simulation and experiments. This model is very efficient and capable of very accurately predicting the resonant frequency for wide range variation of substrate and dielectric cover layers parameters.

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